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| Notice of References Cited | Application/Control No. 10/659,628 | | Applicant(s)/Patent Under Reexamination GUPTA ET AL. | |
| | Examiner Le H. Luu | | Art Unit 2141 | Page 1 of 1 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--------------------------------------------------|-----------------|-----------------------------|----------------|
| * | A | US-2004/0158588 | 08-2004 | Pruet, Clarence Madison III | 707/204 |
| * | B | US-2003/0120635 | 06-2003 | Bousfield et al. | 707/1 |
| * | C | US-5,594,900 | 01-1997 | Cohn et al. | 707/202 |
| * | D | US-6,889,229 | 05-2005 | Wong et al. | 707/102 |
| * | E | US-2004/0030703 | 02-2004 | Bourbonnais et al. | 707/100 |
| * | F | US-6,065,018 | 05-2000 | Beier et al. | 707/202 |
| * | G | US-6,226,651 | 05-2001 | Masuda et al. | 707/202 |
| | H | US- | | | |
| | I | US- | | | |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--------------------------------------------------|-----------------|---------|------|----------------|
| | N | | | | | |
| | O | | | | | |
| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|-------------------------------------------------------------------------------------------|
| | U | |
| | V | |
| | W | |
| | X | |

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